Search Notes (continued)



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/696,937	CHEN ET AL.	
Examiner	Art Unit	
Michael Butler	3653	

SEARCHED				
Class	Subclass	Date	Examiner	
700	223	12/22/2006	MEB	
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EIC DB Search	6/19/2006	MEB		
PLUS DB Search	6/22/2006	MEB		
East DB Search	12/22/2006	MEB		